


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566532	<b>Applicant(s)/Patent Under Reexamination</b>  HAN ET AL.
	<b>Examiner</b>  ANN Y LAM	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner
435	287.2, 287.1, 4, 7.1, 7.92, 7.93	3/25/08	A.L.
	(partial search)		

SEARCH NOTES		
Search Notes	Date	Examiner
east, sequence search	3/25/08	A.L.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner